

# Dynamical focusing of polychromatic beam using Bent Laue Crystal

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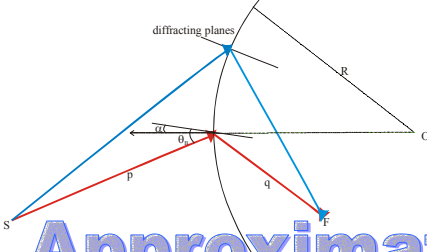
## ABSTRACT

The main limitation in Laue geometry for the achievement of a small focus size, is the focus broadening due to the intrinsic Darwin width and to the spread of the beam in the Borrmann triangle caused by the propagation inside the crystal. We present here a method, based on dynamical focusing, allowing to improve the quality of high energy polychromatic focusing by bent crystals in Laue geometry. This completely wave-optical approach combines the propagation of the wave in the curved crystal, with the equations of Takagi-Taupin, and for the propagation in the free space. Experiment performed on BM5 at ESRF show an excellent agreement with theory [1].

## Geometrical focusing

Geometrical focusing is based on the lens equation presented in many articles<sup>3</sup>:

$$\frac{2}{R} = \frac{\cos(\theta_B - \alpha)}{p} + \frac{\cos(\theta_B + \alpha)}{q} = \frac{\cos \varphi_0}{p} + \frac{\cos \varphi_h}{q} \quad (1)$$



# Approximations in geometrical focusing

**Infinitely narrow beams:**

## Incoherent source-points approximation

Incident radiation on the entrance surface is considered as to be composed of rays each associated to the wavelength obeying the Bragg law at the corresponding entrance surface point.

Apparently this is an approximation because actually the crystal "sees" the whole accepted angular divergence, given approximately by the Darwin width, for every wavelength

Description of incident beam as composed by a distribution of incoherent source-point is only apparently an approximation because from polychromaticity derive incoherence.

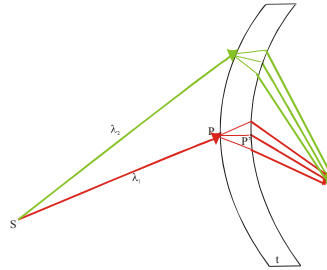
Incoherent source points, equivalent to consider infinitely narrow beam, correctly describe the incoherence of a polychromatic incident beam [2-6].

**Infinitely thin crystal:**

## spreading inside the Borrmann triangle

Considering the thickness of the crystal we have a spreading over the Borrmann triangle.

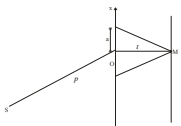
We are interested in finding the conditions for which the diffracted wave from the point-source  $P$  located on the entrance surface converges to a distance  $q$  of the geometric focus.



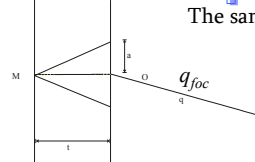
# Focusing of Borrmann triangle after free space propagation

A parallel slab of perfect crystal focus a divergent beam for a suitable thickness [7,8]

The same is true in reciprocal geometry [1]



$$t_{foc} = p \frac{\sqrt{\chi_h \chi_{\bar{h}}}}{2 \sin^2 \theta_B \cos \theta_B}$$



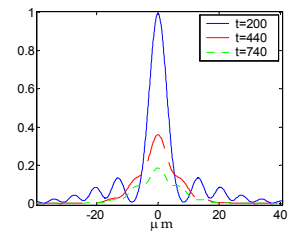
$$q_{foc} = \frac{2 \sin^2 \theta_B \cos \theta_B t}{\sqrt{\chi_h \chi_{\bar{h}}}}$$

In symmetric Laue geometry  $\vec{h} \perp \vec{u}$ , wave propagates inside a cylindrically bent crystal as in an unbent crystal

Si 111  
25 keV

$p=40 \text{ m } q=1.2 \text{ m}$   
 $R=2.9 \text{ m}$

Geometrical focusing  $\rightarrow$  Bending radius  $\rightarrow$  Dynamical Focusing  $\rightarrow$  Focusing thickness



Cross section plot

# Experimental results on wedge crystal

BM 5 - E.S.R.F.

$p=40 \text{ m } q=1.2 \text{ m}$

We use a wedge shaped crystal to test the thickness dependence

Focusing in the horizontal plane

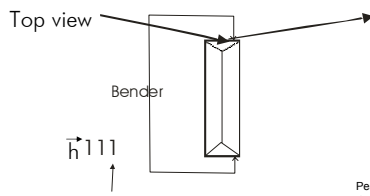
Thin part of the wedge  $\rightarrow$  Central part of the wedge

Focused Beam

Increasing thickness

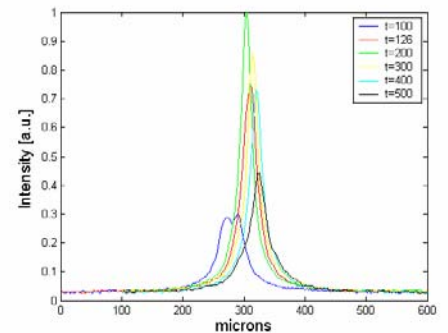


ID24 bender



Peak doubling  $t \sim 100 \mu\text{m}$

$t \sim 250 \mu\text{m}$



$t=200 \mu\text{m}$   
FWHM =  $15 \mu\text{m}$   
Deconvoluted source size FWHM  $6 \mu\text{m}$

## References

- [1] Mocella, V., J. P. Guigay, J. Hrdý, C. Ferrero and J. Hoszowska, *J. Appl. Cryst.* 37, 941-946 (2004). [2] Mocella V., Epelboin Y., Guigay J.P., *Acta Cryst.* A56, 308-316 (2000). [3] Mocella, V., Lee, W. K., Tajiri, G., Mills, D., Ferrero, C., Epelboin, Y., *J. Appl. Cryst.* 36, 129-136 (2003). [4] Carvalho, C.A.M., Epelboin Y., *Acta Cryst.*, A49, 460 (1993); [5] Epelboin, Y., Mocella, V., Soyer, A., *Phil. Trans. R. Soc. A* 357, 2731-2739 (1999) [6] Mocella, V., Epelboin, Y., *J. Appl. Cryst.* 32, 154-159 (1999) [7] Afanas'ev A.M., Khon V. G., *Sov. Phys. Solid State*, 19, 1035-1040 (1977) [8] Aristov et al., *Acta Cryst.* A36, 1002-1013 (1980).